

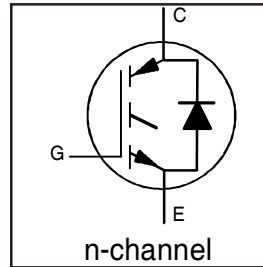
# IRG4IBC20FDPbF

INSULATED GATE BIPOLAR TRANSISTOR WITH  
ULTRAFAST SOFT RECOVERY DIODE

Fast CoPack IGBT

## Features

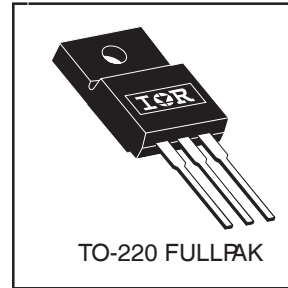
- Very Low 1.66V voltage drop
- 2.5kV, 60s insulation voltage ⑤
- 4.8 mm creepage distance to heatsink
- Fast: Optimized for medium operating frequencies ( 1-5 kHz in hard switching, >20 kHz in resonant mode).
- IGBT co-packaged with HEXFRED™ ultrafast, ultrasoft recovery antiparallel diodes
- Tighter parameter distribution
- Industry standard Isolated TO-220 Fullpak™ outline
- Lead-Free



|                              |
|------------------------------|
| $V_{CES} = 600V$             |
| $V_{CE(on) typ.} = 1.66V$    |
| @ $V_{GE} = 15V, I_C = 9.0A$ |

## Benefits

- Simplified assembly
- Highest efficiency and power density
- HEXFRED™ antiparallel Diode minimizes switching losses and EMI



## Absolute Maximum Ratings

|                           | Parameter                                | Max.                              | Units |
|---------------------------|--|-----------------------------------|-------|
| $V_{CES}$                 | Collector-to-Emitter Voltage             | 600                               | V     |
| $I_C @ T_C = 25^\circ C$  | Continuous Collector Current             | 14.3                              | A     |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current             | 7.7                               |       |
| $I_{CM}$                  | Pulsed Collector Current ①               | 64                                |       |
| $I_{LM}$                  | Clamped Inductive Load Current ②         | 64                                |       |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current         | 6.5                               |       |
| $I_{FM}$                  | Diode Maximum Forward Current            | 64                                |       |
| Visol                     | RMS Isolation Voltage, Terminal to Case③ | 2500                              | V     |
| $V_{GE}$                  | Gate-to-Emitter Voltage                  | $\pm 20$                          |       |
| $P_D @ T_C = 25^\circ C$  | Maximum Power Dissipation                | 34                                | W     |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation                | 14                                |       |
| $T_J$                     | Operating Junction and                   | -55 to +150                       | °C    |
| $T_{STG}$                 | Storage Temperature Range                |                                   |       |
|                           | Soldering Temperature, for 10 sec.       | 300 (0.063 in. (1.6mm) from case) |       |
|                           | Mounting Torque, 6-32 or M3 Screw.       | 10 lbf•in (1.1 N•m)               |       |

## Thermal Resistance

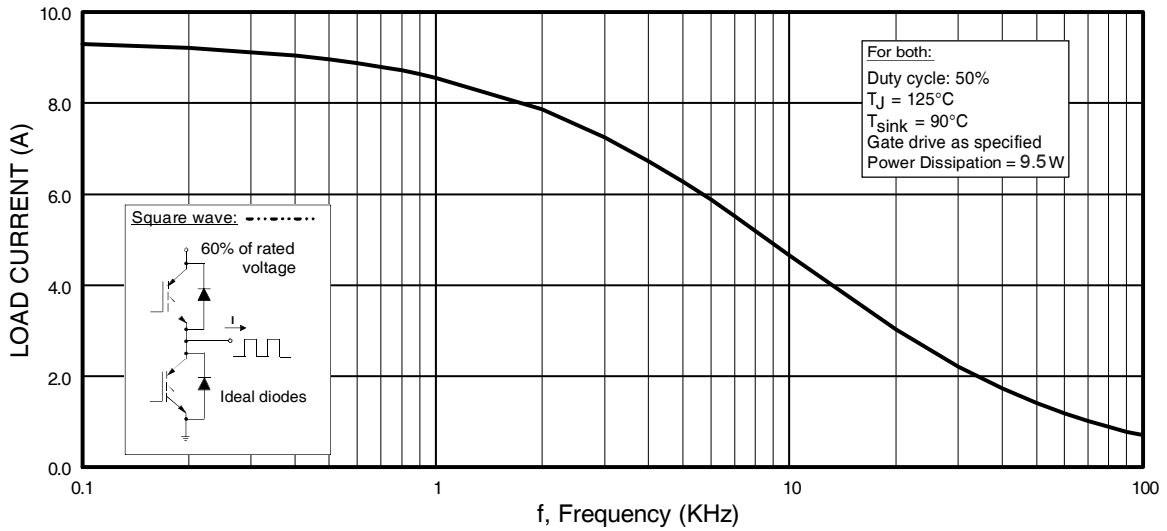
|                 | Parameter                                 | Typ.       | Max. | Units  |
|-----------------|---|------------|------|--------|
| $R_{\theta JC}$ | Junction-to-Case - IGBT                   | —          | 3.7  | °C/W   |
| $R_{\theta JC}$ | Junction-to-Case - Diode                  | —          | 5.1  |        |
| $R_{\theta JA}$ | Junction-to-Ambient, typical socket mount | —          | 65   |        |
| Wt              | Weight                                    | 2.0 (0.07) | —    | g (oz) |

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

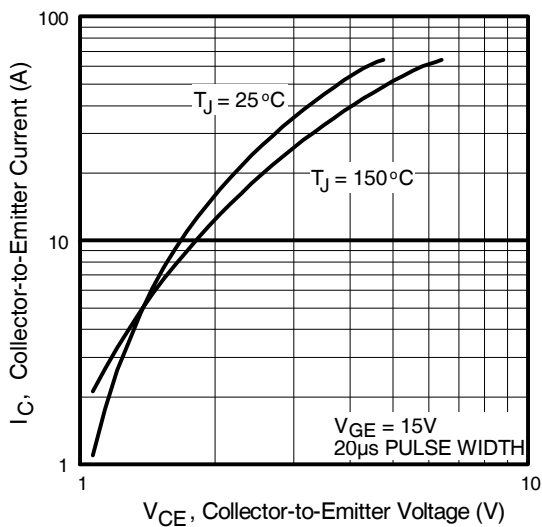
|  | Parameter   | Min. | Typ. | Max. | Units | Conditions   |
|--|---|------|------|------|-------|--|
| V <sub>(BR)CES</sub>                   | Collector-to-Emitter Breakdown Voltage <sup>③</sup> | 600  | —    | —    | V     | V <sub>GE</sub> = 0V, I <sub>C</sub> = 250μA                         |
| ΔV <sub>(BR)CES</sub> /ΔT <sub>J</sub> | Temperature Coeff. of Breakdown Voltage             | —    | 0.72 | —    | V/°C  | V <sub>GE</sub> = 0V, I <sub>C</sub> = 1.0mA                         |
| V <sub>CE(on)</sub>                    | Collector-to-Emitter Saturation Voltage             | —    | 1.66 | 2.0  | V     | I <sub>C</sub> = 9.0A  |
|  |   | —    | 2.06 | —    |       | I <sub>C</sub> = 16A   |
|  |   | —    | 1.76 | —    |       | I <sub>C</sub> = 9.0A, T <sub>J</sub> = 150°C                        |
| V <sub>GE(th)</sub>                    | Gate Threshold Voltage                              | 3.0  | —    | 6.0  |       | V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA           |
| ΔV <sub>GE(th)</sub> /ΔT <sub>J</sub>  | Temperature Coeff. of Threshold Voltage             | —    | -11  | —    | mV/°C | V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA           |
| g <sub>fe</sub>                        | Forward Transconductance <sup>④</sup>               | 2.9  | 5.1  | —    | S     | V <sub>CE</sub> = 100V, I <sub>C</sub> = 9.0A                        |
| I <sub>CES</sub>                       | Zero Gate Voltage Collector Current                 | —    | —    | 250  | μA    | V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V                         |
|  |   | —    | —    | 1700 |       | V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V, T <sub>J</sub> = 150°C |
| V <sub>FM</sub>                        | Diode Forward Voltage Drop                          | —    | 1.4  | 1.7  | V     | I <sub>C</sub> = 8.0A  |
|  |   | —    | 1.3  | 1.6  |       | I <sub>C</sub> = 8.0A, T <sub>J</sub> = 150°C                        |
| I <sub>GES</sub>                       | Gate-to-Emitter Leakage Current                     | —    | —    | ±100 | nA    | V <sub>GE</sub> = ±20V   |

## Switching Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

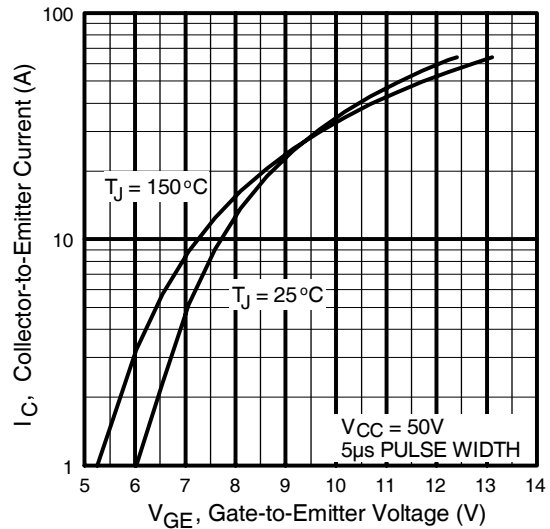
|                          | Parameter   | Min. | Typ. | Max. | Units | Conditions   |
|--------------------------|---|------|------|------|-------|--|
| Q <sub>g</sub>           | Total Gate Charge (turn-on)                               | —    | 27   | 40   | nC    | I <sub>C</sub> = 9.0A                                    |
| Q <sub>ge</sub>          | Gate - Emitter Charge (turn-on)                           | —    | 4.2  | 6.2  |       | V <sub>CC</sub> = 400V                                   |
| Q <sub>gc</sub>          | Gate - Collector Charge (turn-on)                         | —    | 9.9  | 15   |       | V <sub>GE</sub> = 15V                                    |
| t <sub>d(on)</sub>       | Turn-On Delay Time  | —    | 43   | —    | ns    | T <sub>J</sub> = 25°C                                    |
| t <sub>r</sub>           | Rise Time   | —    | 20   | —    |       | I <sub>C</sub> = 9.0A, V <sub>CC</sub> = 480V            |
| t <sub>d(off)</sub>      | Turn-Off Delay Time                                       | —    | 240  | 360  |       | V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω              |
| t <sub>f</sub>           | Fall Time   | —    | 150  | 220  |       | Energy losses include "tail" and diode reverse recovery. |
| E <sub>on</sub>          | Turn-On Switching Loss                                    | —    | 0.25 | —    | mJ    | See Fig. 9, 10, 18                                       |
| E <sub>off</sub>         | Turn-Off Switching Loss                                   | —    | 0.64 | —    |       |  |
| E <sub>ts</sub>          | Total Switching Loss                                      | —    | 0.89 | 1.3  |       |  |
| t <sub>d(on)</sub>       | Turn-On Delay Time  | —    | 41   | —    | ns    | T <sub>J</sub> = 150°C, See Fig. 11, 18                  |
| t <sub>r</sub>           | Rise Time   | —    | 22   | —    |       | I <sub>C</sub> = 9.0A, V <sub>CC</sub> = 480V            |
| t <sub>d(off)</sub>      | Turn-Off Delay Time                                       | —    | 320  | —    |       | V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω              |
| t <sub>f</sub>           | Fall Time   | —    | 290  | —    |       | Energy losses include "tail" and diode reverse recovery. |
| E <sub>ts</sub>          | Total Switching Loss                                      | —    | 1.35 | —    | mJ    |  |
| L <sub>E</sub>           | Internal Emitter Inductance                               | —    | 7.5  | —    | nH    | Measured 5mm from package                                |
| C <sub>ies</sub>         | Input Capacitance   | —    | 540  | —    | pF    | V <sub>GE</sub> = 0V                                     |
| C <sub>oes</sub>         | Output Capacitance  | —    | 37   | —    |       | V <sub>CC</sub> = 30V                                    |
| C <sub>res</sub>         | Reverse Transfer Capacitance                              | —    | 7.0  | —    |       | f = 1.0MHz   |
| t <sub>rr</sub>          | Diode Reverse Recovery Time                               | —    | 37   | 55   | ns    | T <sub>J</sub> = 25°C See Fig. 14                        |
|                          |   | —    | 55   | 90   |       | T <sub>J</sub> = 125°C                                   |
| I <sub>rr</sub>          | Diode Peak Reverse Recovery Current                       | —    | 3.5  | 5.0  | A     | T <sub>J</sub> = 25°C See Fig. 15                        |
|                          |   | —    | 4.5  | 8.0  |       | T <sub>J</sub> = 125°C                                   |
| Q <sub>rr</sub>          | Diode Reverse Recovery Charge                             | —    | 65   | 138  | nC    | T <sub>J</sub> = 25°C See Fig. 16                        |
|                          |   | —    | 124  | 360  |       | T <sub>J</sub> = 125°C                                   |
| di <sub>(rec)</sub> M/dt | Diode Peak Rate of Fall of Recovery During t <sub>b</sub> | —    | 240  | —    | A/μs  | T <sub>J</sub> = 25°C See Fig. 17                        |
|                          |   | —    | 210  | —    |       | T <sub>J</sub> = 125°C                                   |



**Fig. 1 - Typical Load Current vs. Frequency**  
 (Load Current =  $I_{\text{RMS}}$  of fundamental)

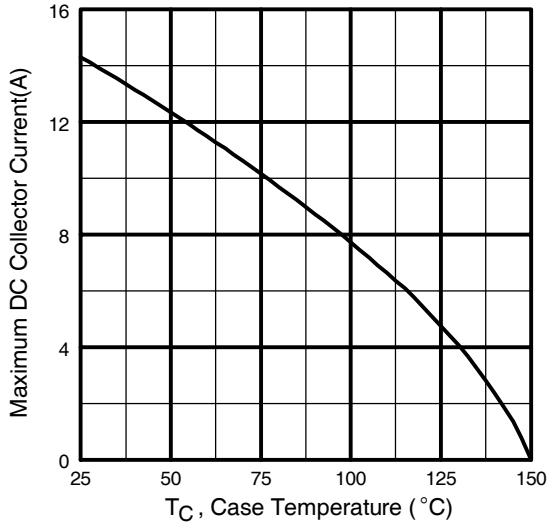


**Fig. 2 - Typical Output Characteristics**  
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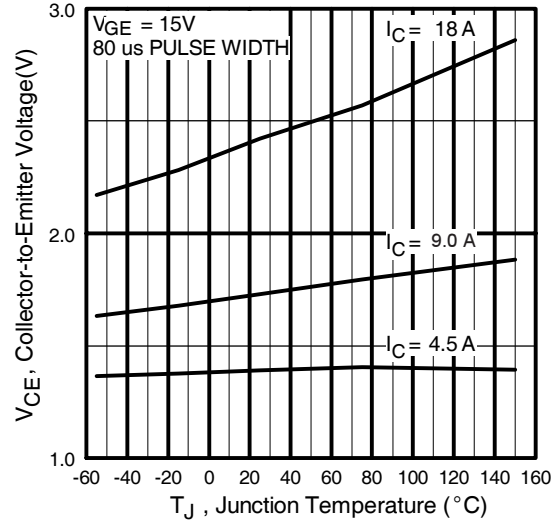


**Fig. 3 - Typical Transfer Characteristics**

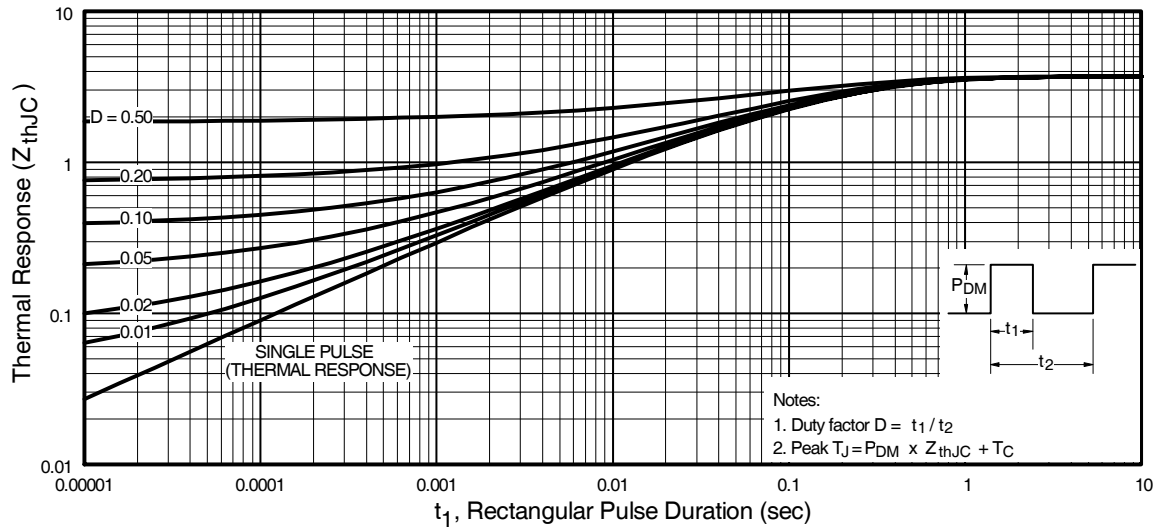
# IRG4IBC20FDPbF



**Fig. 4** - Maximum Collector Current vs. Case Temperature

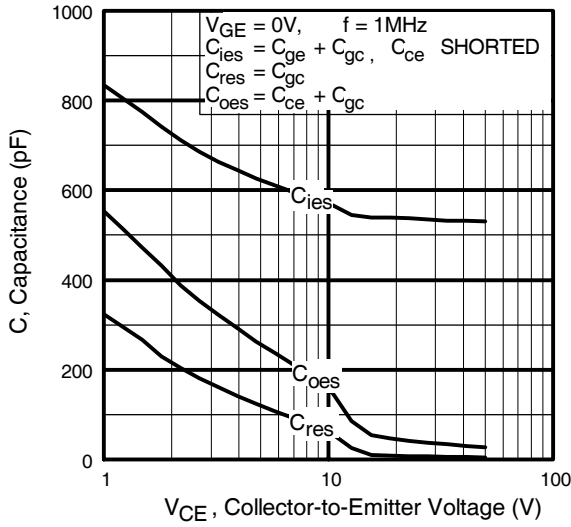


**Fig. 5** - Typical Collector-to-Emitter Voltage vs. Junction Temperature

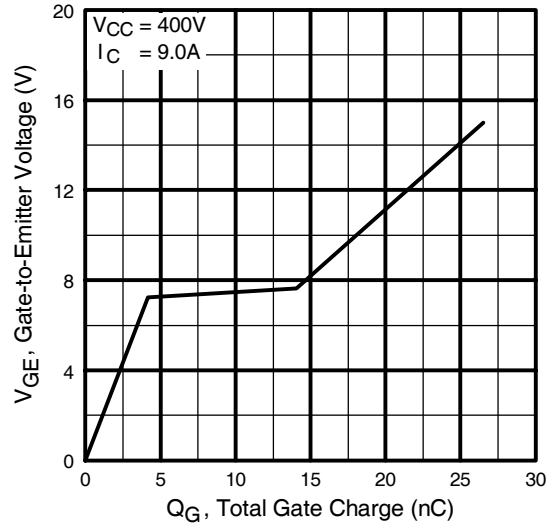


**Fig. 6** - Maximum Effective Transient Thermal Impedance, Junction-to-Case

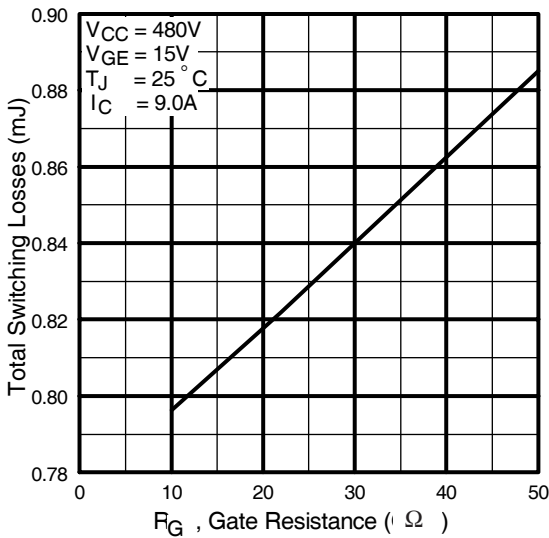
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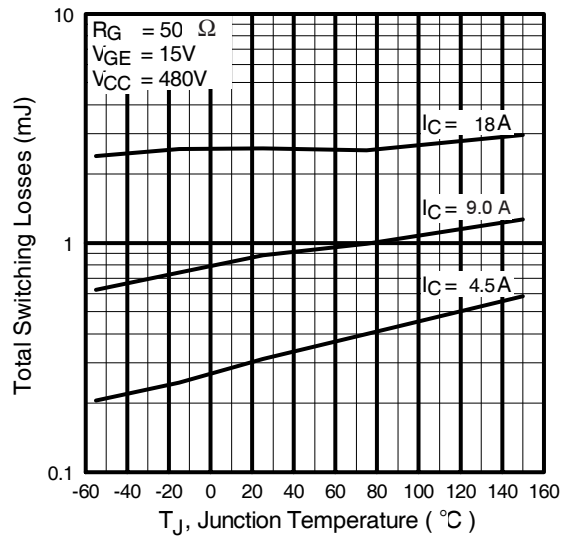
**Fig. 7** - Typical Capacitance vs. Collector-to-Emitter Voltage



**Fig. 8** - Typical Gate Charge vs. Gate-to-Emitter Voltage

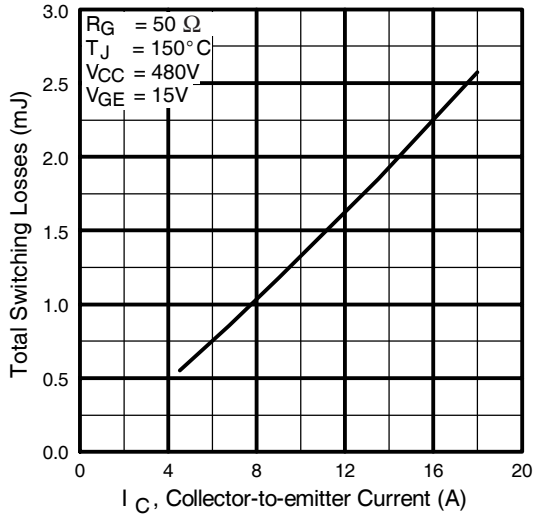


**Fig. 9** - Typical Switching Losses vs. Gate Resistance

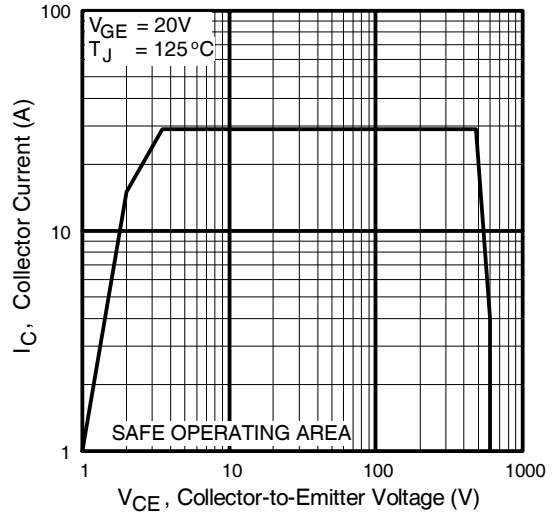


**Fig. 10** - Typical Switching Losses vs. Junction Temperature

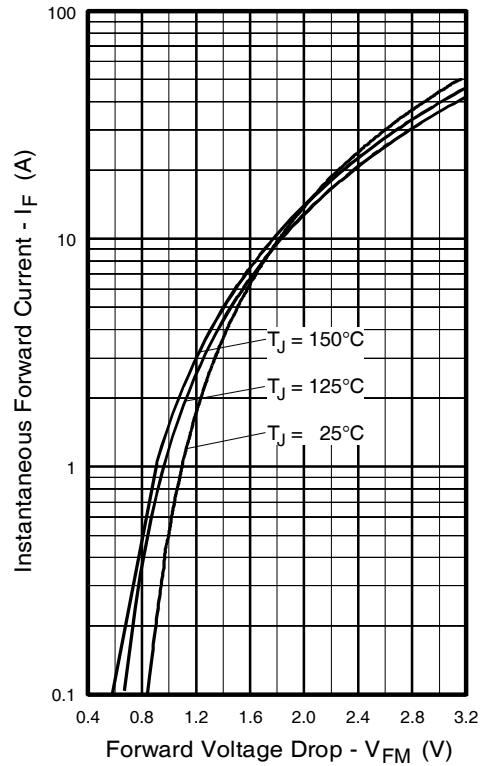
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**Fig. 11** - Typical Switching Losses vs. Collector-to-Emitter Current



**Fig. 12** - Turn-Off SOA



**Fig. 13** - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

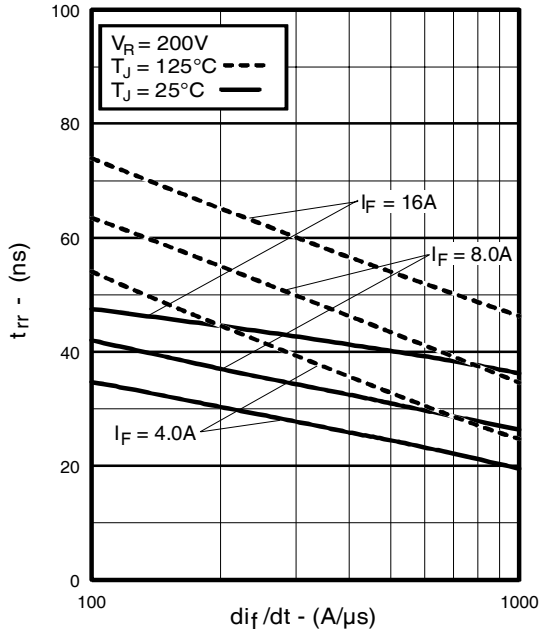


Fig. 14 - Typical Reverse Recovery vs.  $di_f/dt$

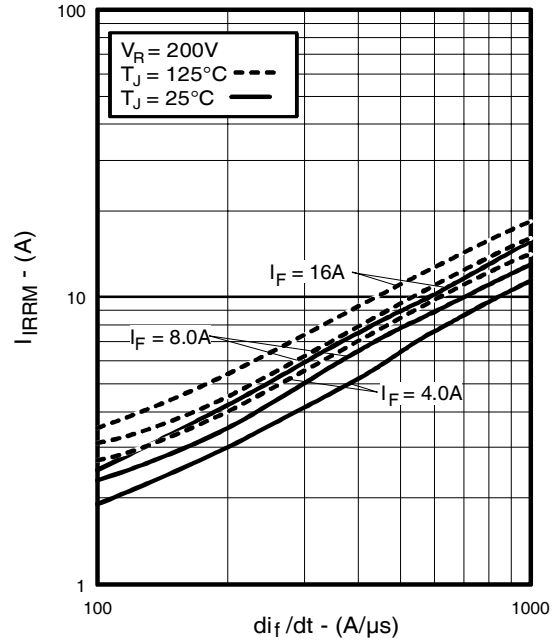


Fig. 15 - Typical Recovery Current vs.  $di_f/dt$

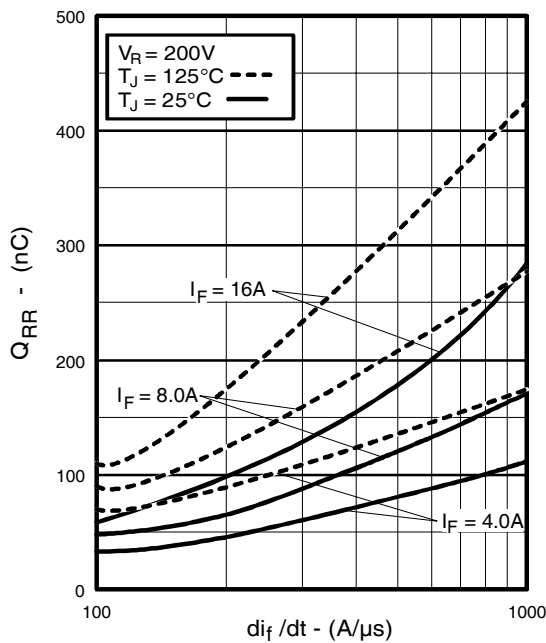


Fig. 16 - Typical Stored Charge vs.  $di_f/dt$   
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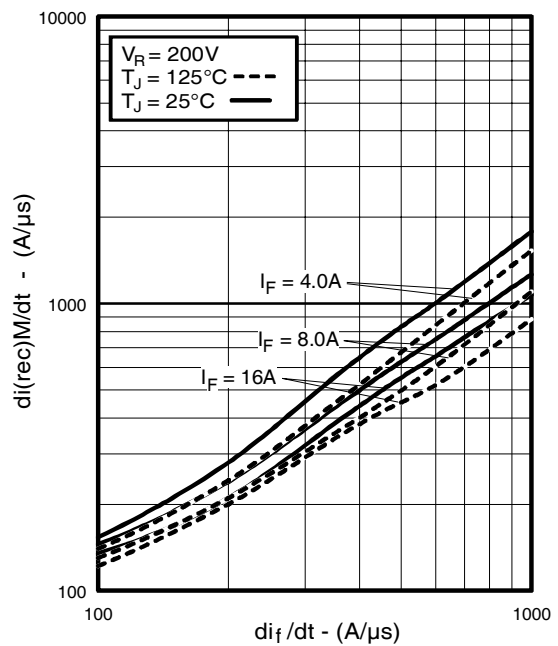
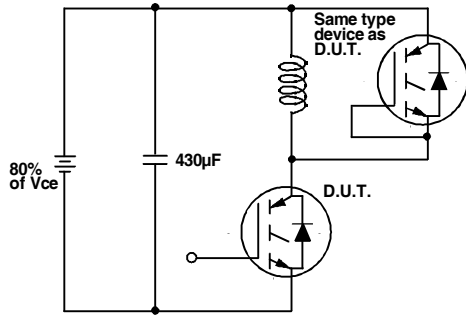
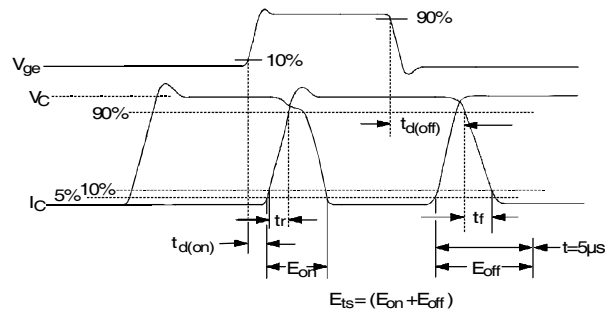


Fig. 17 - Typical  $di_{(rec)M}/dt$  vs.  $di_f/dt$

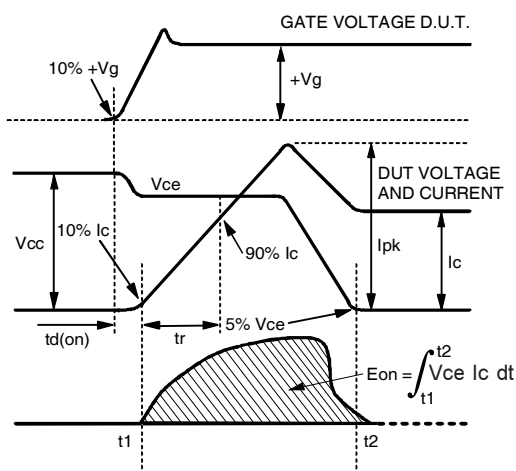
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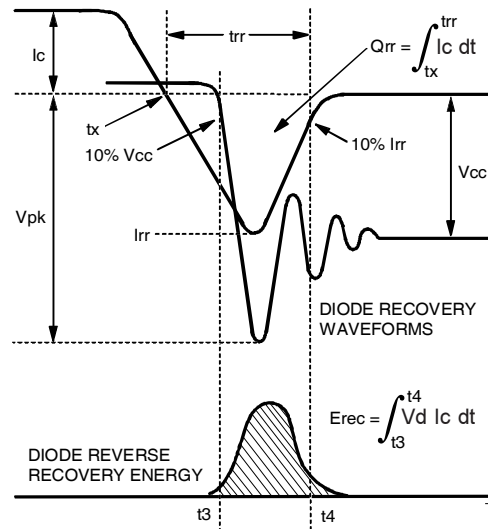
**Fig. 18a** - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off}(\text{diode})$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_{d(on)}$ ,  $t_r$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18b** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18c** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$



**Fig. 18d** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{rec}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$



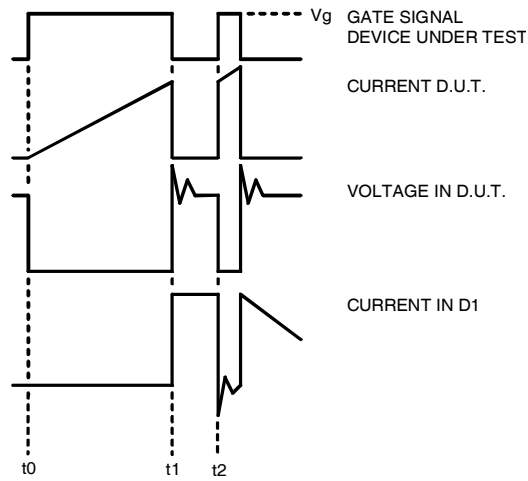


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

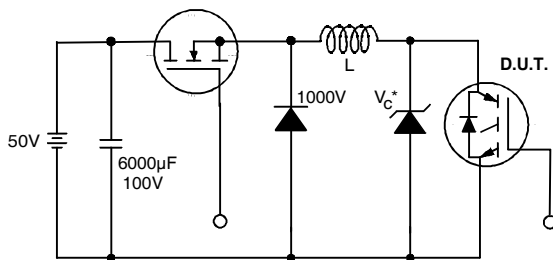


Figure 19. Clamped Inductive Load Test Circuit

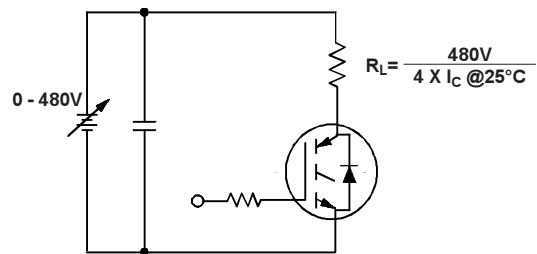


Figure 20. Pulsed Collector Current Test Circuit

